## Notice of References Cited

Application/Control No. 10/627,612	Reexamination	Applicant(s)/Patent Under Reexamination CHEN, YU SHENG		
Examiner	Art Unit			
Kiet Doan	2683	Page 1 of 1		

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2003/0202486 A1	10-2003	Anton et al.	370/329
	В	US-2004/0022210 A1	02-2004	Frank et al.	370/328
	С	US-2004/0127185 A1	07-2004	Abrahams et al.	455/277.1
	D	US-2004/0209615 A1	10-2004	Lamb et al.	455/433
	E	US-2002/0039882 A1	04-2002	Ternullo et al.	455/11.1
	F	US-2003/0210658 A1	11-2003	Hernandez et al.	370/311 .
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				·	
	Q				,	
	R	;				
	S		·			
	т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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